## Notice of References Cited

Application/Control No. 10/518,581	Applicant(s)/P Reexamination VERMA ET Al	n
Examiner	Art Unit	
Jean A. Gelin	2681	Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,721,578	04-2004	Minear et al.	455/566
	В	US-2002/0172368	11-2002	Peterka, Petr	380/278
	С	US-2004/0010602	01-2004	Van Vleck et al.	709/229
	D	US-6,868,440	03-2005	Gupta et al.	709/219
	E	US-2002/0087656	07-2002	Gargiulo et al.	709/217
	F	US-2004/0128324	07-2004	Sheynman et al.	707/200
	G	US-2002/0123336	09-2002	Kamada, Tomihisa	455/420
	Η	US-2002/0176382	11-2002	Madour et al.	370/331
	ı	US-2003/0065802	04-2003	Vitikainen et al.	709/231
	J	US-2004/0005900	01-2004	Zilliacus, Martin	455/466
	К	US-6,546,243	04-2003	Tiedemann et al.	455/419
	L	US-6,846,239	01-2005	Washio, Kazuto	463/40
	М	US-2004/0081110	04-2004	Koskimies, Oskari	370/315

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
-	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	, U	
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	w	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.